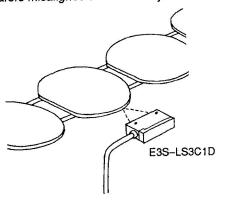
16 Wafer Detection (Edge)

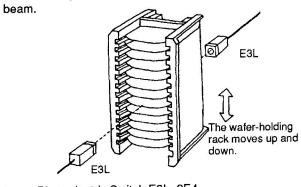
Sensor spot light is wider than the wafer edge, so it can detect wafers misaligned on the conveyor.



Amp (Internal) Photoelectric Switch E3S-LS3C1D Limited Reflection Type

17 Wafer Number Detector

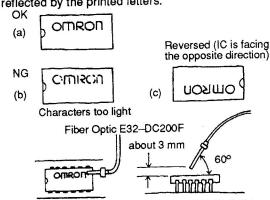
Conventional photo sensors have wide beams that may not detect properly due to reflection from other wafers. This detector uses a narrow photo laser switch beam, and has a 0.1-mm slit to focus the



Laser Photoelectric Switch E3L-2E4 (with 0.1 mm dia. slit)

18 Marking Machine Print Error Detection

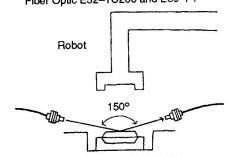
Uses a fiber sensor tilted at a 60° angle to detect light reflected by the printed letters.



E3XR-CE4 Fiber Optic Photoelectric Switch E32-DC200F

19 IC Detection

Uses a transparent optical fiber mounted diagonally to detect light reflected from the IC surface. A long-distance lens unit to gather light accurately even from low-reflectivity IC surfaces. Sensor is mounted at an angle. Fiber Optic E32-TC200 and E39-F1

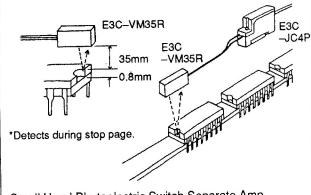


Fiber Optic Photoelectric Switch E3XR-CE4 E32-TC200 Amp Unit

Distant Lens Unit E39-F1

20 IC Index Detection

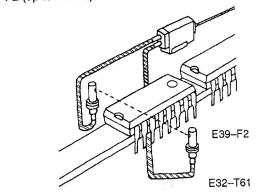
Detects indexes accurately with the small 1.0-mm spotlight from 35 mm.



Small Head Photoelectric Switch Separate Amp Photoelectric Switch E3C-VM35R (Sensor) E3C-JC4P (Amp)

21 IC Detection in Handler

A heat-resistant fiber unit and a side-view lens unit that can be used under high temperature conditions without taking up space. E32-T61 (up to 300°C). E39-F2 (up to 200°C).



Fiber Optic Photoelectric Switch